

PATENT



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Andrei NIKULIN
 Application No. : 10/518,651
 Filed : July 18, 2005
 For : METHODS AND APPARATUS OF SAMPLE ANALYSIS

Examiner : Courtney D. Thomas
 Art Unit : 2882
 Docket No. : 671096.403USPC
 Date : April 27, 2007

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Mail Stop Amendment
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 P.O. Box 1450
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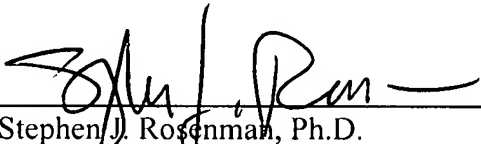
In accordance with 37 CFR 1.56 and 1.97 through 1.98, applicant wishes to make known to the U.S. Patent and Trademark Office the references set forth on the attached Information Disclosure Statement. Copies of cited U.S. patents and published patent applications are not required and accordingly have not been provided. Copies of any other cited references are enclosed. As to any reference cited, applicant does not admit that it is "prior art" under 35 U.S.C. §§ 102 or 103, and specifically reserves the right to traverse or antedate any such reference, as by a showing under 37 CFR 1.131 or other method. Although the aforesaid references are made known to the Patent and Trademark Office in compliance with applicant's duty to disclose all information he is aware of which is believed relevant to the examination of the above-identified application, applicant believes that his invention is patentable.

Please acknowledge receipt of this Information Disclosure Statement and kindly make the cited references of record in the above-identified application.

A fee of \$180 is submitted in accordance with 37 CFR 1.97(c). The Director is authorized to charge any other fees which may be required, or credit any overpayment to Deposit Account No. 19-1090.

Respectfully submitted,

Seed Intellectual Property Law Group PLLC



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Registration No. 43,058

SJR:rp

Enclosures:

Check

Supplemental Information Disclosure Statement

Cited References (3)

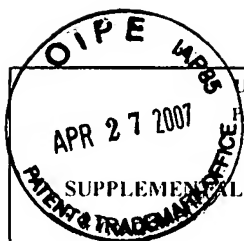
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PATENT AND TRADEMARK OFFICESUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT
(Use several sheets if necessary)ATTY. DOCKET NO.
671096.403USPCAPPLICATION NO.
10/518,651APPLICANTS
Andrei NIKULINFILING DATE
July 18, 2005GROUP ART UNIT
2882

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AI					
	AJ					
	AK					
	AL					
	AM					

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	AN	Siu, Karen, et al., "X-ray phase retrieval in high-resolution refraction data from amorphous materials," <i>Applied Physics Letters</i> , 79(13):2112-2114, September 24, 2001.
	AO	Siu, Karen, et al., "Phase Retrieval X-ray Diffractometry (PRXRD): Refraction/Small angle scattering data applications," <i>Proc. SPIE, Advances in X-Ray Optics</i> , 4145: 157-167, 2001.; Abstract (1 page).
	AP	Siu, Karen, et al., "An application of phase retrieval x-ray diffractometry to refraction/small-angle scattering data," <i>J. Phys. D: Appl. Phys.</i> , 34: 2912-2917, 2001.

EXAMINER

DATE CONSIDERED

* EXAMINER: Initial if reference considered, whether or not criteria is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant(s).